

**Search Notes**

Application/Control No.

10/780,607

Examiner

Raymond Phan

Applicant(s)/Patent under  
Reexamination

TAKEDA ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	309-315, 111-113, 36-39	11/24/2005	RP
710	7-8,52-54	11/24/2005	RP
710	240-241	11/25/2005	RP
711	167-169	11/26/2005	RP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/25/2005	RP